

## Fabrication of Channels for Nanobiotechnological Devices

Nanolithography would not be necessary for establishing channel depths and thicknesses.

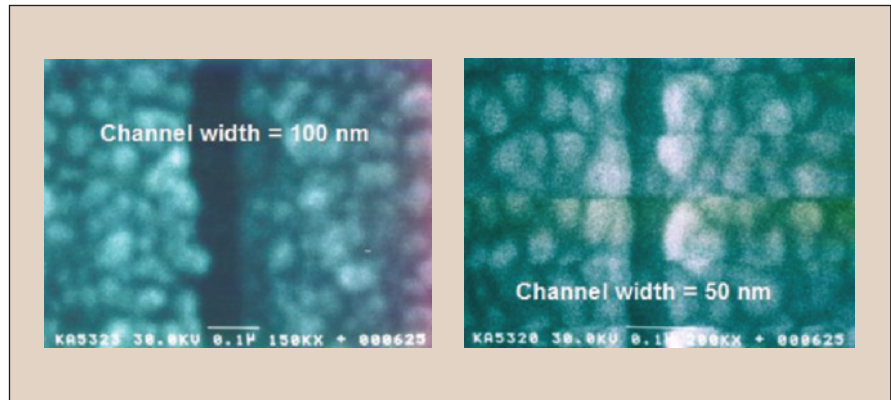
NASA's Jet Propulsion Laboratory, Pasadena, California

A method, now undergoing development, of forming nanochannels in planar substrates is intended to enable the fabrication of advanced fluidic devices that could be integrated with complementary metal oxide semiconductor (CMOS) electronic circuits. Such integral combinations of fluidic and electronic components ("laboratory-on-a-chip" devices) could be used, for example, to detect individual molecules of deoxyribonucleic acid (DNA) and proteins. The width of a channel in such a device would be chosen so that molecules of the species of interest would move along the channel in single file.

In addition to being intended to enable the tailoring of the width of each channel to a uniform value of the order of several nanometers, the developmental method is intended to satisfy the following other requirements:

- A channel must be optically transparent when viewed along a line perpendicular to the plane of the substrate;
- The process of formation of the channels must be compatible with CMOS circuitry and with the processes of fabrication of CMOS circuitry;
- Relative to processes that have been used to fabricate devices containing microchannels, this process must be simple.

In this method, the fabrication of channels includes the use of such CMOS-compatible processes as chemical-mechanical polishing and oxide deposition. The layout of the channels in the substrate plane is determined by a single photolithographic process, but it is not a nanoscale lithographic process, and this process is



These **Scanning Electron Micrographs** show channels of two different widths that were fabricated by the present method. In a finished device, the channels would be covered with an SiO<sub>2</sub> membrane, which would be sufficiently transparent to enable analysis of specimens in the channels by use of a fluorescence microscope.

not relied upon to define the thickness and width of the channels. Stating it from a slightly different perspective, unlike in the prior fabrication of electronic and fluidic devices involving the use of lithography to define microscale features, this process does not include the use of lithography to define nanoscale features. It is this aspect of the method that enables simplification of the process and, hence, a decrease in cost.

A typical fabrication process according to this method includes, among other things, thermal oxidation to form a layer of SiO<sub>2</sub> on a silicon substrate, followed by deposition of a layer of Si<sub>3</sub>N<sub>4</sub>, followed by deposition of a first layer of polycrystalline silicon (poly-Si). The depth of the channel(s) is determined by the thickness of the first poly-Si layer. The width of the channels (see figure) is determined

by the thickness of the SiO<sub>2</sub> layer, which thickness is readily controllable and can be made extremely uniform.

*This work was done by Choonsup Lee and Eui-Hyeok Yang of Caltech for NASA's Jet Propulsion Laboratory. Further information is contained in a TSP (see page 1).*

*In accordance with Public Law 96-517, the contractor has elected to retain title to this invention. Inquiries concerning rights for its commercial use should be addressed to:*

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## Improved Thin, Flexible Heat Pipes

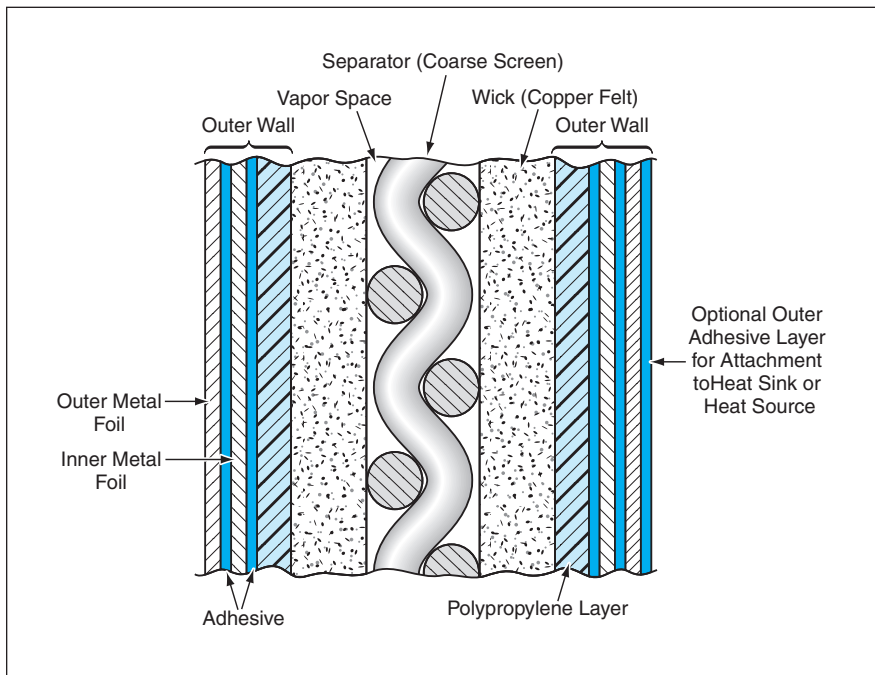
Like common tapes, these heat pipes can be adhesively bonded to curved objects.

Lyndon B. Johnson Space Center, Houston, Texas

Flexible heat pipes of an improved type are fabricated as layers of different materials laminated together into vacuum-tight sheets or tapes. In comparison with prior flexible heat pipes, these flexi-

ble heat pipes are less susceptible to leakage. Other advantages of these flexible heat pipes, relative to prior flexible heat pipes, include high reliability and greater ease and lower cost of fabrication. Be-

cause these heat pipes are very thin, they are highly flexible. When coated on outside surfaces with adhesives, these flexible heat pipes can be applied, like common adhesive tapes, to the surfaces of



A Flexible Heat Pipe can be fabricated as a laminate of polypropylene, metal, and adhesive layers. This enlarged cross section of a typical preferred laminate is not to scale.

heat sinks and objects to be cooled, even if those surfaces are curved.

A preferred design calls for five major layers (see figure) laminated to a total thickness of 0.12 in. (3 mm). The middle layer is a coarse metal (e.g., copper) or polypropylene screen that acts as a separator to maintain the heat-pipe vapor space by separating two other major layers, which are copper felt wicks. The remaining two major layers,

which are sealed together around their edges, are outer walls that constitute the heat-pipe envelope around the wicks and separator. Each outer wall comprises a strengthening sublayer of polypropylene, two sublayers of metal foil, and sublayers adhesive between the polypropylene and metal layers.

The wick layers can be pressed into the polypropylene wall layers (optionally with partial melting of the polypropy-

lene layers) to increase the thermal conductance between the walls and wicks. The two outer walls are joined at their edges by placing their polypropylene layers in contact and then heating them and pressing them together.

The two metal foils in each outer wall serve as barriers against leakage. Because foils occasionally contain random pinholes, one foil layer per wall would not afford sufficient protection against leaks. However, when an outer wall contains two foil layers, it would be necessary for two pinholes to be aligned with each other (a highly improbable occurrence) to make a pinhole leak. Hence, the use of two foil layers per outer wall reduces the probability of pinhole leaks to a small value.

*This work was done by John H. Rosenfeld, Nelson J. Gernert, David B. Sarraf, Peter J. Wollen, Frank C. Surina, and John E. Fale of Thermacore, Inc., for Johnson Space Center. Further information is contained in a TSP (see page 1).*

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